



15EC63

(05 Marks)

(06 Marks) (05 Marks)

USN

Sixth Semester B.E. Degree Examination, June/July 2018 VLSI Design

Time: 3 hrs.

Max. Marks: 80

Note: Answer any FIVE full questions, choosing one full question from each module.

Module-1 Discuss the working of nMOS enhancement mode transistor operation with neat diagrams. (06 Marks) Explain the CMOS inverter DC characteristics highlighting the regions of operation. (10 Marks) OR (09 Marks) With neat diagrams discuss the nMOS fabrication process steps. Explain the following: (1) Channel length modulation (07 Marks) (ii) Noise Margin Module-2 (05 Marks) Discuss the CMOS design style with a diagram. Draw the stick diagram for the following using CMOS logic: (05 Marks) (ii) 2 i/p NAND gate Y = A + B + CDiscuss the different contact cuts with an example to each. (06 Marks) With a diagram derive an expression for sheet resistance and mention the Rs values of metal, (05 Marks) p and n transistor channels for 5 µm technology. Derive an equation for rise time and fall time with respect to CMOS inverter. (08 Marks) Draw the circuit and stick diagram for 2 i/p NOR gate using CMOS logic. (03 Marks) Module-3 Explain the constant field, constant voltage scaling models with a diagram and scaling effect (06 Marks) Discuss the problems associated in VLSI design. How do you reduce them? (05 Marks) (05 Marks) Discuss the different bus architectures. OR (07 Marks) Discuss the design of a 4-bit adder. (05 Marks) With relevant diagram discuss Manchester carry chain operation. (04 Marks) Explain the carry select adder with a diagram. Module-4

a. Discuss the programmable logic array with its structure and floor plan.

b. Discuss the architectural issues related to VLSI sub system design.

c. Discuss the design of Data selectors.



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OR

Explain the architecture of field programmable gate array. (10 Marks) (06 Marks) Discuss the FPGA abstractions with a diagram Module-5 Explain three transistor DRAM with its diagram and stick diagram. (07 Marks) Discuss the ASM chart for JK flip flop with its NAND logic arrangement. (09 Marks) OR Explain logic verification process with its functional equivalence diagram. (06 Marks) 10 a. (06 Marks) Discuss the design for manufacturability. (04 Marks) Discuss the Ad-hoc testing.

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